

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/739,351	TAKAHASHI ET AL.	
Examiner Jeffrie R. Lund		Art Unit 1763	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/39493 A1	05-2002	PCT	Ogasawara et al	--
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	WEBSTER'S II New Riverside University Dictionary, 1994, page 695 "linear".
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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